SN54198, SN54199 SN74198, SN74199 **8-BIT SHIFT BEGISTERS**

SDLS078

description

These 8-bit shift registers are compatible with most other TTL and MSI logic families. All inputs are buffered to lower the drive requirements to one normalized Series 54/74 load, and input clamping diodes minimize switching transients to simplify system design. Maximum input clock frequency is typically 35 megahertz and power dissipation is typically 360 mW.

Series 54 devices are characterized for operation over the full military temperature range of -55°C to 125°C; Series 74 devices are characterized for operation from 0°C to 70°C.

SN54198 and SN74198

These bidirectional registers are designed to incorporate virtually all of the features a system designer may want in a shift register. These circuits contain 87

equivalent gates and feature parallel inputs, parallel outputs, right-shift and left-shift serial inputs, operating-modecontrol inputs, and a direct overriding clear line. The register has four distinct modes of operation, namely:

> Inhibit Clock (Do nothing) Shift Right (In the direction Q_{Δ} toward Q_{H}) Shift Left (In the direction Q_H toward Q_A) Parallel (Broadside) Load

Synchronous parallel loading is accomplished by applying the eight bits of data and taking both mode control inputs, S0 and S1, high. The data is loaded into the associated flip-flop and appears at the outputs after the positive transition of the clock input. During loading, serial data flow is inhibited.

Shift right is accomplished synchronously with the rising edge of the clock pulse when S0 is high and S1 is low, Serial data for this mode is entered at the shift-right data input. When S0 is low and S1 is high, data shifts left synchronously and new data is entered at the shift-left serial input,

Clocking of the flip-flop is inhibited when both mode control inputs are low. The mode controls should be changed only while the clock input is high.

					140					
	FUNCTION TABLE									
	INPUTS									
	МС	DE		SERIAL I		PARALLEL			_	_
CLEAR	S ₁	S ₀	CLOCK	LEFT	RIGHT	ΑΗ	QA.	α ₈	۵G	QH
L	X	х	X	×	X	x	L	L	L	L
н	x	х	L	×	х	x	QA0	QB0	Q_{GO}	QH0
Н	н	н	5	×	×	ah	а	ь	g	h
н	L	н	Ť	×	н	x	н	QAD	QEn	QGn
н	L	н	т	x	L	x	L	Q _{An}	OFn	QGn
н	н	L.	t	н	х	x	QBn	QCn	Q _{Hn}	н
н	н	L	t	L	х	x	0 _{Bn}	0 _{Cn}	Q _{Hn}	L
н	L	L	×	х	x	x	0 _{A0}	0 ₈₀	a _{G0}	a _{H0}

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H = high level (steady state), L = low level (steady state)

X = irrelevant (any input, including transitions)

† = transition from low to high level

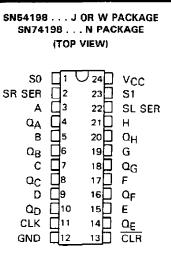
a... h = the level of steady-state input at inputs A thru H, respectively.

QAO, QBO, QGO, QHO = the level of QA, QB, QG, or QH, respectively, before the indicated steady-state input conditions were established. $\Omega_{An}, \Omega_{Bn}, etc. = the level of <math>\Omega_A, \Omega_B, etc., respectively, before the most-recent <math>\uparrow$ transition of the clock.

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard werrenty. Production processing does not necessarily include testing of all parameters.



DECEMBER 1972-REVISED MARCH 1988



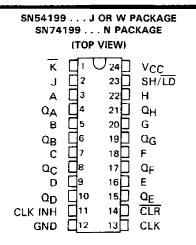
SN54198, SN54199 SN74198, SN74199 8-BIT SHIFT REGISTERS

SN54199 and SN74199

These registers feature parallel inputs, parallel outputs, $J \cdot \overline{K}$ serial inputs, shift/load control input, a direct overriding clear line, and gated clock inputs. The register has three modes of operation:

Inhibit Clock (Do nothing) Shift (In the direction Q_A toward Q_H) Parallel (Broadside) Load

Parallel loading is accomplished by applying the eight bits of data and taking the shift/load control input low when the clock input is not inhibited. The data is loaded into the associated flip-flop and appears at the outputs after the positive transition of the clock input. During loading, serial data flow is inhibited.



Shifting is accomplished synchronously when shift/load is high and the clock input is not inhibited. Serial data for this mode is entered at the $J_{-\overline{K}}$ inputs. See the function table for levels required to enter serial data into the first flip-flop.

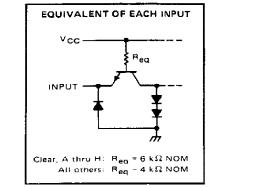
Both of the clock inputs are identical in function and may be used interchangeably to serve as clock or clock-inhibit inputs. Holding either high inhibits clocking, but when one is held low, a clock input applied to the other input is passed to the eight flip-flops of the register. The clock-inhibit input should be changed to the high level only while the clock input is high.

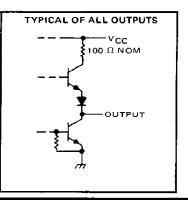
These shift registers contain the equivalent of 79 TTL gates. Average power dissipation per gate is typically 4.55 mW.

	FONCTION TABLE															
	INPUTS									OUTPUTS						
CLEAR	SHIFT/	CLOCK	CLOCK	SEF		PARALLEL	QA	a _B	٥c	Q _H						
	LOAD	INHIBIT		J	K	AH	-			••						
L L	×	x	X	X	х	×	ι .	L	L	L						
н	х	L	L	х	х	х	O _{A0}	a _{B0}	σ^{C0}	a _{H0}						
н	L	L	t	х	х	ah	а	b	с	h						
н	н	L	i	L	н	x	Q _{A0}	Q _{A0}	QBn	Q _{Gn}						
н	н	L	!	L	L	х	L	Q _{An}	∆ B∩	Q _{Gn}						
н	н	L	1	н	H	x	н	Ω _{An}	Ω _{βn}	0 _{Gn}						
н	н	L	t	н	L	x	0 _{An}	QAn	Q _{Bn}	QGn						
н	х	н	t	х	х	x	O _{AO}	Q _{B0}	0 ₈₀	QHO						

'199 FUNCTION TABLE

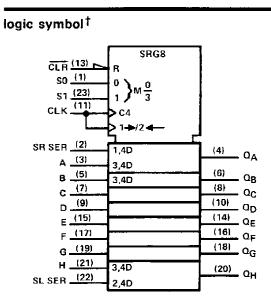
schematics of inputs and outputs



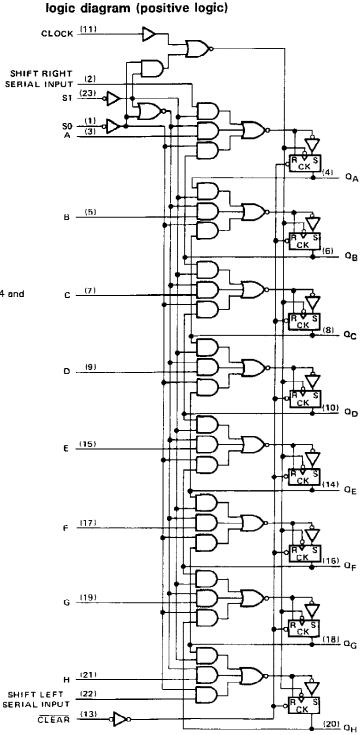


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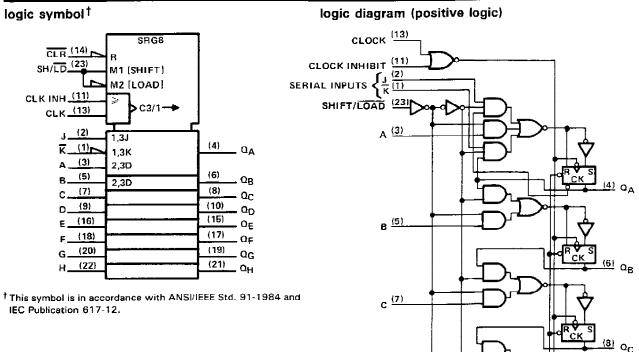
SN54198, SN74198 8-BIT SHIFT REGISTERS

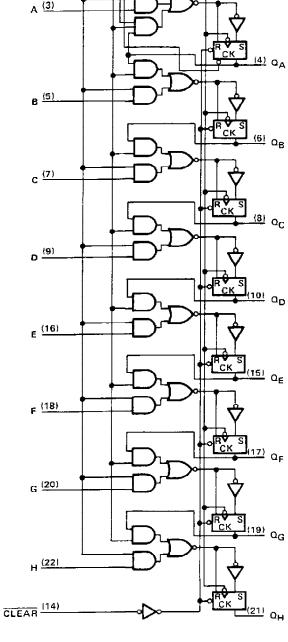


[†] This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.



SN54199, SN74199 8-BIT SHIFT REGISTERS

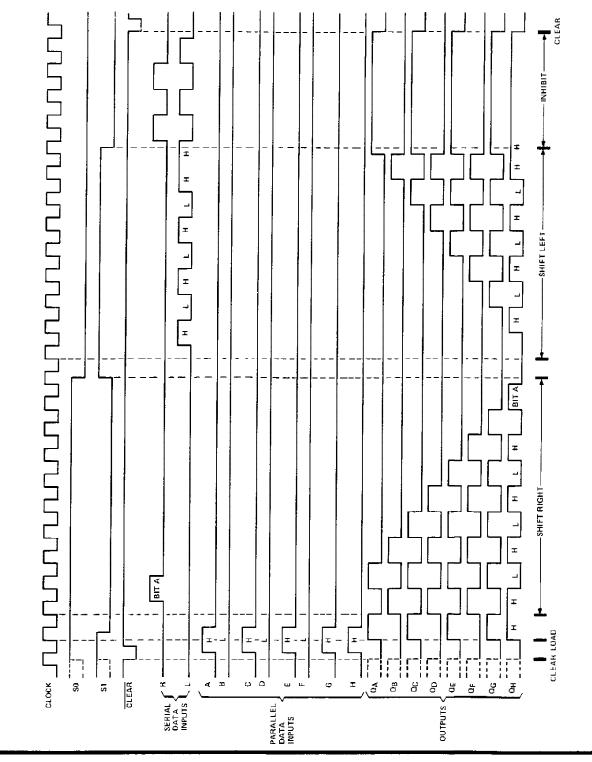






SN54198, SN74198

typical clear, load, right-shift, left-shift, inhibit, and clear sequences

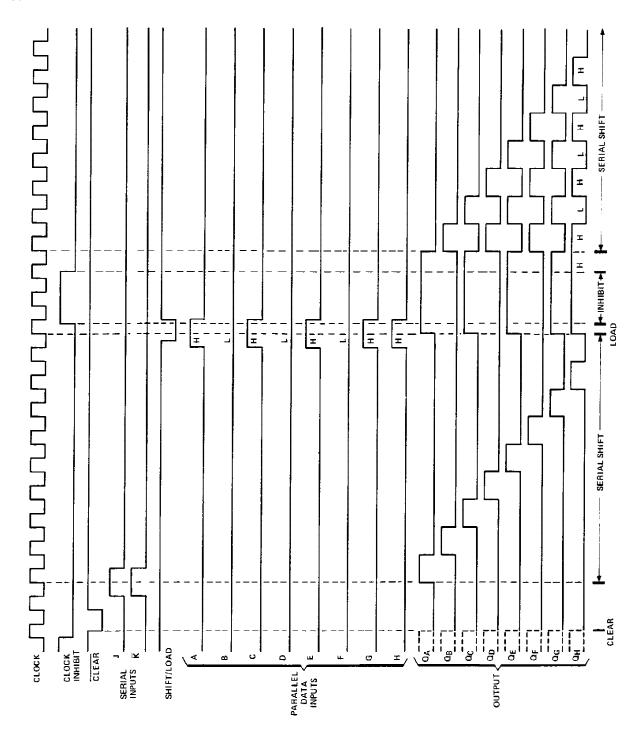




SN54199, SN74199 8-BIT SHIFT REGISTERS

SN54199, SN74199

typical clear, shift, load, and inhibit sequences



TEXAS TEXAS INSTRUMENTS

SN54198, SN54199, SN74198, SN74199 8-BIT SHIFT REGISTERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)																		7V
Input voltage				-			-				-							5.5 V
Operating free-air temperature range:	SN54	Circuits					•											–55°C to 125°C
								-			•							. 0°C to 70°C
Storage temperature range			•	•	·	• •	•	•	•	 ٠	٠	•	•	•	•	٠	•	–65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	SN54198 SN54199			9	UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX	1
Supply voltage, VCC	4.5	5	5.5	4.75	5	5.25	v
High-level output current, IOH		-	-800			-800	μA
Low-level output current, IOL			16			16	mA
Clock frequency, fclock	0		25	0		25	MHz
Width of clock or clear pulse, tw (see Figure 1)	20			20			ns
Mode-control setup time, t _{su}	30			30			пs
Data setup time, t _{su} (see Figure 1)	20			20			ns
Hold time at any input, th (see Figure 1)	0			0			ns
Operating free-air temperature, TA	-55		125	0	-	70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS [†]		SN5419 SN5419			UNIT		
			MIN	ТҮР‡	MAX	MIN	TYPI	MAX	1
⊻ін	High-level input voltage		2			2			V
۷ _{IL}	Low-level input voltage				0.8	1		0.8	V
Vik	Input clamp voltage	$V_{CC} = MIN$, $I_{\uparrow} = -12 \text{ mA}$			-1.5			-1.5	V
∨он	High-level output voltage	V _{CC} = MIN, V _{1H} = 2 V, V _{IL} = 0.8 V, I _{OH} = -800 μA	2.4	3.4		2.4	3.4		v
VOL	Low-level output voltage	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OL} = 16 mA		0,2	0.4		0.2	0.4	v
11	Input current at maximum input voltage	V _{CC} = MAX, V _I = 5.5 V			1			1	mA
ін	High-level input current	V _{CC} = MAX, V ₁ = 2,4 V			40			40	μA
٦L _	Low-level input current	V _{CC} = MAX, V ₁ = 0.4 V			-1.6			-1.6	mA
IOS	Short-circuit output current \$	V _{CC} = MAX	-20		-57	-18	-	-57	mA
lcc	Supply current	VCC = MAX, See Table Below	1	90	127		90	127	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 \ddagger All typical values are at V $_{CC}$ = 5 V, T $_{A}$ = 25 $^{\circ}C$ $_{\odot}$

\$ Not more than one output should be shorted at a time.

TEST CONDITIONS FOR ICC (ALL OUTPUTS ARE OPEN)

[T		FIRST GROUND,	
TYPE	APPLY 4.5 V	THEN APPLY 4.5 V	GROUND
SN54198, SN74198	Serial Input, So, S1	Clock	Clear, Inputs A thru H
SN54199, SN74199	J, K, Inputs A thru H	Clock	Clock inhibit, Clear, Shift/Load

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SN54198, SN54199, SN74198, SN74199 8-BIT SHIFT REGISTERS

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
finax	Maximum clock frequency		25	35		MHz
	Propagation delay time, high-to-					
^t PHL	low-level output from clear			23	35	ns
	Propagation delay time, high-to-	$C_{L} = 15 pF$, $R_{L} = 400 \Omega$,				—
(PHL	low-level output from clock	See Figure 1		20	30	ns
	Propagation delay time, low-to-					
^t PLH	high-level output from clock			17	26	ns



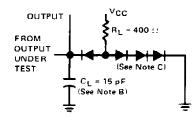
SN54198, SN54199, SN74198, SN74199 **8-BIT SHIFT REGISTERS**

PARAMETER MEASUREMENT INFORMATION

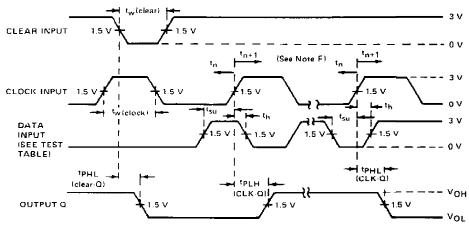
SN54199, SN74199

TEST TABLE FOR SYNCHRONOUS INPUTS DATA INPUT OUTPUT TESTED 51 so FOR TEST (SEE NOTE E) 45 V 45 V А QA at tn+1 в 4.5 V 4.5 V QB at tn+1 С QC at tn+1 4.5 V 4.5 V D 4.5 V 4.5 V QD at tn+1 Е 4.5 V QE at t_{n+1} 4.5 V F QF at t_{n+1} 4.5 V 4.5 V G 4.5 V 4.5 V QG at tn+1 н 4.5 V 4.5 V Q_H at t_{n+1} L Serial Input 4.5 V nγ QA at tn+8 οv 4.5 V R Serial Input QH at tn+8

DATA INPUT FOR TEST	SHIFT/LOAD	OUTPUT TESTED (SEE NOTE E)
A	οv	O _A at t _{n+1}
Б	0 V	Q _B at t _{n+1}
с	οv	QC at tn+1
D	0 V	QD at t _{n+1}
E	0 V	QE at tn+1
F	0 V	Ω _F att _{n+1}
G	0 V	Q _G at t _{n+1}
н	0 V	QH at tn+1
Jand K	4.5 V	Ω _H at t _{n+8}



LOAD FOR OUTPUT UNDER TEST



VOLTAGE WAVEFORMS

- NOTES: A. The clock pulse has the following characteristics: tw(clock) = 20 ns and PRR = 1 MHz. The clear pulse has the following characteristics: $t_w(clear) = 20$ ns and $t_{hold} = 0$ ns. When testing f_{max} , vary the clock PRR.
 - B. CL includes probe and jig capacitance.
 - C. All diodes are 1N3064.
 - D. A clear pulse is applied prior to each test.
 - E. Propagation delay times (tpLH and tpHL) are measured at tn+1. Proper shifting of data is verified at tn+8 with a functional test. F. t_0 = bit time before clocking transition
 - $t_{n+1} \in \text{bit time after one clocking transition}$ $t_{n+8} > bit time after eight clocking transitions$

FIGURE 1



SN54198, SN74198 TEST TABLE FOR SYNCHRONOUS INPUTS

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